Microstructurally-Informed Random Field Description: Case Study on Chaotic Masonry

M. Lombardo¹ <u>J. Zeman</u>² M. Šejnoha^{2,3}

¹Civil and Building Engineering Loughborough University

²Department of Mechanics ³Centre for Integrated Design of Advanced Structures Faculty of Civil Engineering Czech Technical University in Prague

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Motivation: Analysis of a historic masonry wall



Key issues

- Heterogeneity and non-uniformity of the structure
- Size of constituents not negligible with respect to structural length
- Random morphology of the material
- Available modeling concepts

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 - Homogenization approaches
 - Stochastic media theories

Motivation: Homogenization vs random fields





- Rapidly oscillating coefficients
- Assumes scale separation
- Periodic unit cell (PUC)
- Random materials \rightarrow SEPUC
- Explicit treatment of heterogeneity (ZEMAN & ŠEJNOHA, MSMSE, 2007)

- Random coefficients
- No a-priory scale separation
- Random field construction
- Randomness is "for free"
- Link with microstructure?

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Quantification of random morphology

Statistics of structural response

- Improved perturbation technique
- Karhunen-Loève expansion
- Hashin-Shtrikman approach

3 Numerical example



Quantification of random morphology

- Elementary geometrical descriptors of random media
 - One-point correlation function $S_s^{(1)} \equiv \gamma_s$ (volume fraction)
 - Two-point correlation function $S_s^{(2)}(m,n)$
- STONES environment (FALSONE & LOMBARDO, 2006)



Quantification of random morphology

Implications for random field description

• Consider a discrete binary random field $\chi_s: \Omega \times S \to \{0, 1\}$

$$\chi_s(\mathbf{x}, \theta) = \begin{cases} 1 & \text{if } \mathbf{x} \in \text{stone}(\theta) \\ 0 & \text{if } \mathbf{x} \in \text{mortar}(\theta) \end{cases} \qquad \mathbb{E}[\chi_s(\mathbf{x})] = \gamma_s \\ \mathbb{E}[\chi_s(\mathbf{x})\chi_s(\mathbf{y})] = S_s^{(2)}(\mathbf{x} - \mathbf{y}) \end{cases}$$

• For a general binary field $f: \Omega \times S \to \mathbb{R}$

$$f(\mathbf{x}, \theta) = \begin{cases} f^{(s)} & \text{if } \mathbf{x} \in \text{stone}(\theta) \\ f^{(m)} & \text{if } \mathbf{x} \in \text{mortar}(\theta) \end{cases}$$

Basic statistical characterization

$$\mathbb{E}[f(\mathbf{x})] = \gamma_s f^{(s)} + (1 - \gamma_s) f^{(m)}$$

$$R_{fg}(\mathbf{x} - \mathbf{y}) = \left(S_s^{(2)}(\mathbf{x} - \mathbf{y}) - \gamma_s^2\right) \left(f^{(s)} - f^{(m)}\right) \left(g^{(s)} - g^{(m)}\right)$$

• Rigorous microstructure-based description

• Elasticity problem on Ω with stochastic material data

$$\mathbf{C}(\mathbf{x},\theta) = \chi_s(\mathbf{x},\theta)\mathbf{C}^{(s)} + (1-\chi_s(\mathbf{x},\theta))\mathbf{C}^{(m)}$$

Discretization of Ω by N_e elements (2h ≤ correlation length)
 Midpoint discretization of random field:

$$oldsymbol{\chi}^h_s(heta) = ig[\chi^h_{s,1}(heta),\chi^h_{s,2}(heta)\ldots,\chi^h_{s,N_e}(heta)ig]^{\mathsf{T}} \in \{0,1\}^{N_e}$$

- Discretized FEM equations: $\mathbf{K}(\boldsymbol{\chi}^h_s(\theta))\boldsymbol{u}^h(\theta) = \boldsymbol{F}$
- Elementary statistics of displacements

$$\mathbf{A}\,\mathbb{E}[\boldsymbol{u}^h]=\boldsymbol{F}$$

where

$$\mathbf{A} = \mathbf{K}_0 - \sum_{i=1}^{N_e} \sum_{j=1}^{N_e} \mathbf{K}'_i (\mathbf{K}_0)^{-1} \mathbf{K}'_j \mathbb{E}[\chi_{s,i} \chi_{s,j}]$$

Karhunen-Loève expansion

• Karhunen-Loève expansion of a stationary random field $g(\mathbf{x}, \theta)$

$$g(\mathbf{x}, \theta) = \mathbb{E}[g] + \sum_{i=1} \sqrt{\lambda_i} f_i(\mathbf{x}) \xi(\theta),$$
$$\int_{\Omega} R_g(\mathbf{x} - \mathbf{y}) f_i(\mathbf{y}) \, \mathrm{d}\mathbf{y} = \lambda_i f_i(\mathbf{x}) \qquad \xi_i(\theta) = \frac{1}{\sqrt{\lambda_i}} \int_{\Omega} \left(g(\mathbf{x}, \theta) - \mathbb{E}[g] \right) f_i(\mathbf{x}) \, \mathrm{d}\mathbf{x}$$

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Karhunen-Loève expansion



Karhunen-Loève expansion

- Spatial dimensional x is accurately captured
- Stochastic dimension θ: Truncated Gaussian variables



• Evaluation of statistics: Monte-Carlo integration

$$\mathbb{E}[\boldsymbol{u}] \approx \frac{1}{N_s} \sum_{s=1}^{N_s} \boldsymbol{u}^h(\theta_i)$$

with $N_s = 10,000$

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Hashin-Shtrikman approach

LUCIANO & WILLIS, 2005,2006



- Reference body Ω with stiffness ${\bf C}_0$
- Stress equivalence condition

$$\boldsymbol{\sigma}(\boldsymbol{x},\theta) = \mathbf{C}(\boldsymbol{x},\theta)\boldsymbol{\varepsilon}(\boldsymbol{x},\theta) = \mathbf{C}_0\boldsymbol{\varepsilon}(\boldsymbol{x},\theta) + \boldsymbol{\tau}(\boldsymbol{x},\theta)$$

Approximate solution of reference problem using FEM

$$\boldsymbol{\varepsilon}_0^h(\boldsymbol{x}), \ \mathbf{G}_0^h(\boldsymbol{x}, \boldsymbol{y}) = \mathbf{N}_u^h(\boldsymbol{x})(\mathbf{K}_0^h)^{-1}\mathbf{B}^{h\mathsf{T}}(\boldsymbol{y}), \ \boldsymbol{\Gamma}_0^h(\boldsymbol{x}, \boldsymbol{y}) = \mathbf{B}^h(\boldsymbol{x})(\mathbf{K}_0^h)^{-1}\mathbf{B}^{h\mathsf{T}}(\boldsymbol{y})$$

Hashin-Shtrikman approach: Polarization problem

- Polarization stress: $\tau^h(\mathbf{x}, \theta) = \mathbf{N}^h(\mathbf{x}) \left(\chi_1(\mathbf{x}, \theta) \mathbf{d}_1^h + \chi_2(\mathbf{x}, \theta) \mathbf{d}_2^h \right)$
- Discretized version of H-S variational principles

$$\mathbf{K}_i^h \boldsymbol{d}_i^h + \sum_j \mathbf{K}_{ij}^h \boldsymbol{d}_j^h = \boldsymbol{R}_i^h$$

$$\begin{split} \mathbf{K}_{i}^{h} &= \int_{\Omega} \gamma_{i}(\mathbf{x}) \mathbf{N}^{h\mathsf{T}}(\mathbf{x}) \left[\mathbf{C}_{i} - \mathbf{C}_{0} \right]^{-1} \mathbf{N}^{h}(\mathbf{x}) \, \mathrm{d}\mathbf{x} \\ \mathbf{K}_{ij}^{h} &= \int_{\Omega} \mathbf{N}^{h\mathsf{T}}(\mathbf{x}) \int_{\Omega} S_{ij}^{(2)}(\mathbf{x} - \mathbf{y}) \mathbf{\Gamma}_{0}^{h}(\mathbf{x}, \mathbf{y}) \mathbf{N}^{h}(\mathbf{y}) \, \mathrm{d}\mathbf{x} \, \mathrm{d}\mathbf{y} \\ \mathbf{R}_{i}^{h} &= \int_{\Omega} \gamma_{i}(\mathbf{x}) \mathbf{N}^{h\mathsf{T}}(\mathbf{x}) \boldsymbol{\varepsilon}_{0}^{h}(\mathbf{x}) \, \mathrm{d}\mathbf{x} \end{split}$$

Statistics of the solution:

$$\mathbb{E}[\boldsymbol{u}^{h}(\boldsymbol{x})] = \boldsymbol{u}_{0}^{h}(\boldsymbol{x}) - \int_{\Omega} \mathbf{G}_{0}^{h}(\boldsymbol{x}, \boldsymbol{y}) \mathbf{N}^{h}(\boldsymbol{y}) \left(\gamma_{1}\boldsymbol{d}_{1}^{h} + \gamma_{2}\boldsymbol{d}_{2}^{h}\right) \, \mathrm{d}\boldsymbol{y}$$

Numerical example

q=0.1 MPa (uniform pressure)



Phase	E [MPa]	ν[-]
Stone	12 500	0.2
Mortar	1 200	0.3
Q1/(Q0) elements		

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Improved perturbation method (25×25 elements)



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Numerical example



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Numerical example



- Spatial correlation of a random field can be directly obtained from samples of microstructure
- Improved perturbation method seems to fully utilize second-order data, but it inconsistent with the H-S bounds
- Karhunen-Loeve expansion needs a large number of terms for realistic structures
- Results of Hashin-Shtrikman method strongly depend on the choice of reference media
- Need for a rational construction of non-Gaussian fields with prescribed correlation structure

Additional info available at

http://www.arxiv.org/abs/0811.0972

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